

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner THANH Y. TRAN		Art Unit 2892	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0190294	12-2002	Iizuka et al.	257/296
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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